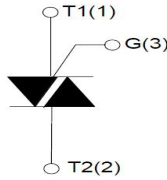
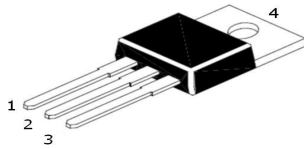


## 16A TRIACS



**BTA16-600/800/1200**  
**TO-220 (Ins)**  
**Plastic Package**

**BTB16-600/800/1200**  
**TO-220 (Non-Ins)**  
**Plastic Package**

BTA16 series triacs, with high ability to withstand the shock loading of large current, provide high dv/dt rate with strong resistance to electromagnetic interference. With high commutation performances, 3 quadrant products especially recommended for use on inductive load.

### ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Storage junction temperature range	$T_{stg}$	-40 to 150	°C
Operating junction temperature range	$T_j$	-40 to 125	°C
Repetitive peak off-state voltage ( $T_j=25^\circ\text{C}$ )	$V_{DRM}$	600/800/1200	V
Repetitive peak reverse voltage ( $T_j=25^\circ\text{C}$ )	$V_{RRM}$	600/800/1200	V
Non repetitive surge peak Off-state voltage	$V_{DSM}$	$V_{DRM} + 100$	V
Non repetitive peak reverse voltage	$V_{RSM}$	$V_{RRM} + 100$	V
RMS on-state current	TO-220 (Ins) ( $T_c=86^\circ\text{C}$ )	16	A
	TO-220 (Non-Ins) ( $T_c=107^\circ\text{C}$ )		
Non repetitive surge peak on-state current (full cycle, $F=50\text{Hz}$ )	$I_{TSM}$	160	A
$I^2t$ value for fusing ( $t_p=10\text{ms}$ )	$I^2t$	128	$\text{A}^2\text{s}$
Critical rate of rise of on-state current ( $I_G = 2 \times I_{GT}$ )	$di/dt$	50	$\text{A}/\mu\text{s}$
Peak gate current	$I_{GM}$	4	A
Average gate power dissipation	$P_{G(AV)}$	1	W
Peak gate power	$P_{GM}$	5	W

**ELECTRICAL CHARACTERISTICS** ( $T_j=25^\circ\text{C}$  unless otherwise specified)

**3 Quadrants ( $V_{\text{DRM}}/V_{\text{RRM}} : 600/800\text{V}$ )**

PARAMETER	TEST CONDITIONS	SYMBOL	QUADRANT	VALUES				UNITS
				BW	CW	SW	TW	
Gate Trigger Current	$V_D = 12\text{V } R_L = 33\Omega$	$I_{\text{GT}}$	I - II - III	<50	<35	<10	<5	mA
Gate Trigger Voltage		$V_{\text{GT}}$	I - II - III	<1.3				V
Off-State Gate Voltage	$V_D = V_{\text{DRM}} T_j = 125^\circ\text{C}$ $R_L = 3.3\text{K}\Omega$	$V_{\text{GD}}$	I - II - III	>0.2				V
Latching Current	$I_G = 1.2I_{\text{GT}}$	$I_L$	I - III	<70	<50	<30	<15	mA
			II	<80	<60	<40	<20	
Holding Current	$I_T = 100\text{mA}$	$I_H$		<60	<40	<25	<15	mA
Critical Rate of Rise of Off-State Voltage	$V_D = 2/3V_{\text{DRM}}$ Gate Open $T_j = 125^\circ\text{C}$	dV/dt		>1000	>500	>200	>100	V/ $\mu\text{s}$

**4 Quadrant ( $V_{\text{DRM}}/V_{\text{RRM}} : 600/800\text{V}$ )**

PARAMETER	TEST CONDITIONS	SYMBOL	QUADRANT	VALUES		UNITS
				B	C	
Gate Trigger Current	$V_D = 12\text{V } R_L = 33\Omega$	$I_{\text{GT}}$	I - II - III	<50	<25	mA
			IV	<70	<50	
Gate Trigger Voltage	$V_D = 12\text{V } R_L = 33\Omega$	$V_{\text{GT}}$	ALL	<1.5		V
Off-State Gate Voltage	$V_D = V_{\text{DRM}} T_j = 125^\circ\text{C}$ $R_L = 3.3\text{K}\Omega$	$V_{\text{GD}}$	ALL	>0.2		V
Latching Current	$I_G = 1.2I_{\text{GT}}$	$I_L$	I - III - IV	<70	<50	mA
			II	<100	<80	
Holding Current	$I_T = 100\text{mA}$	$I_H$		<60	<40	mA
Critical Rate of Rise of Off-State Voltage	$V_D = 2/3V_{\text{DRM}}$ Gate Open $T_j = 125^\circ\text{C}$	dV/dt		>500	>200	V/ $\mu\text{s}$

### 3 Quadrants ( $V_{DRM}/V_{RRM}$ : 1200V)

PARAMETER	TEST CONDITIONS	SYMBOL	QUADRANT	VALUES	UNITS
Gate Trigger Current	$V_D = 12V$ $R_L = 33\Omega$	$I_{GT}$	I - II - III	<50	mA
Gate Trigger Voltage		$V_{GT}$	I - II - III	<1.5	V
Off-State Gate Voltage	$V_D = V_{DRM}$ $T_j = 125^\circ C$ $R_L = 3.3K\Omega$	$V_{GD}$	I - II - III	>0.2	V
Latching Current	$I_G = 1.2I_{GT}$	$I_L$	I - III	<70	mA
			II	<90	
Holding Current	$I_T = 100mA$	$I_H$		<60	mA
Critical Rate of Rise of Off-State Voltage	$V_D = 2/3V_{DRM}$ Gate Open $T_j = 125^\circ C$	dV/dt		>1500	V/ $\mu s$

### STATIC CHARACTERISTICS

PARAMETER	TEST CONDITIONS	SYMBOL	VALUE (MAX)			UNITS
			-600V	-800V	-1200V	
On-State Voltage	$I_{TM} = 22.5A$ $t_p = 380\mu s$	$T_j = 25^\circ C$	1.5			V
Off-State Leakage Current	$V_D = V_{DRM}$ , $V_R = V_{RRM}$	$T_j = 25^\circ C$	5	5	10	$\mu A$
		$T_j = 125^\circ C$	2	2	1	mA

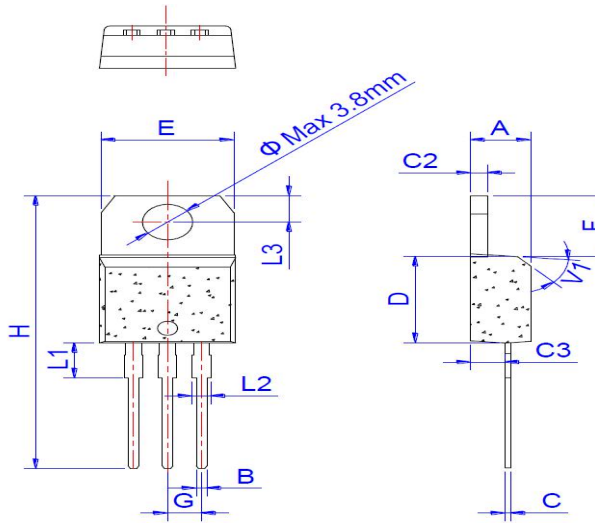
### THERMAL RESISTANCES

PARAMETER	SYMBOL	VALUE (MAX)	UNITS
Maximum Thermal Resistance	$R_{th(j-c)}$	2.1	$^\circ C/W$
		1.2	

### ORDERING INFORMATION

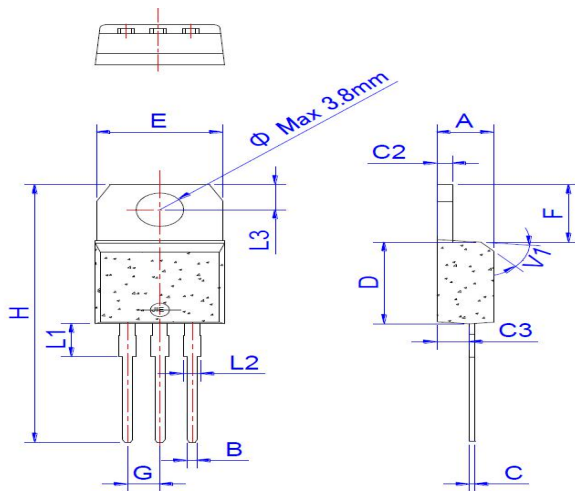
<b>BTA12-XY</b> <b>BTB12-XY</b>	
<b>X</b> = 600: $V_{DRM}/V_{RRM} \geq 600$ = 800: $V_{DRM}/V_{RRM} \geq 800$ = 1200: $V_{DRM}/V_{RRM} \geq 1200$	<b>Y</b> = BW: $I_{GT1-3} \leq 50mA$ = CW: $I_{GT1-3} \leq 35mA$ = SW: $I_{GT1-3} \leq 10mA$ = TW: $I_{GT1-3} \leq 5mA$ = B: $I_{GT1-3} \leq 50mA$ $I_{GT4} \leq 70mA$ = C: $I_{GT1-3} \leq 25mA$ $I_{GT4} \leq 50mA$

### TO-220 (Ins) PACKAGE OUTLINE AND DIMENSIONS



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
B	0.61		0.88	0.024		0.035
C	0.46		0.70	0.018		0.028
C2	1.21		1.32	0.048		0.052
C3	2.40		2.72	0.094		0.107
D	8.60		9.70	0.339		0.382
E	9.80		10.4	0.386		0.409
F	6.55		6.95	0.258		0.274
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.75			0.148	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
V1		45°			45°	

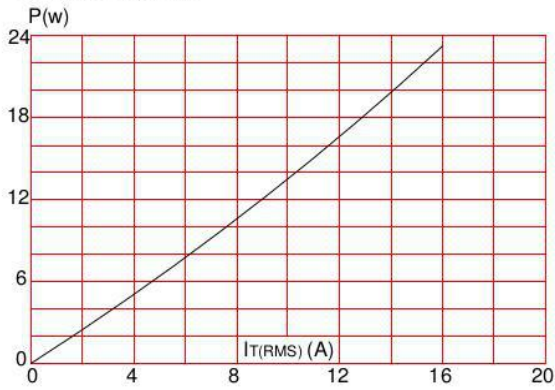
### TO-220 (Non-Ins) PACKAGE OUTLINE AND DIMENSIONS



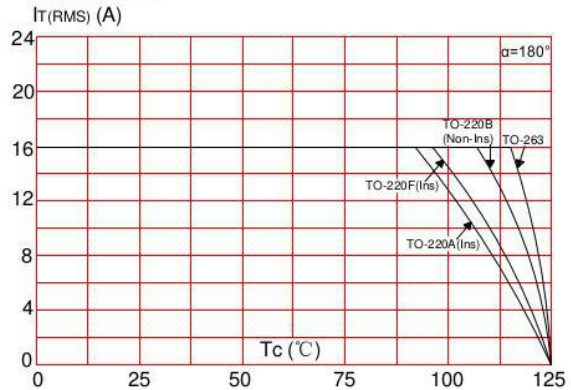
Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
B	0.61		0.88	0.024		0.035
C	0.46		0.70	0.018		0.028
C2	1.21		1.32	0.048		0.052
C3	2.40		2.72	0.094		0.107
D	8.60		9.70	0.339		0.382
E	9.60		10.4	0.378		0.409
F	6.20		6.60	0.244		0.260
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.75			0.148	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
V1		45°			45°	

### CHARACTERISTIC CURVES

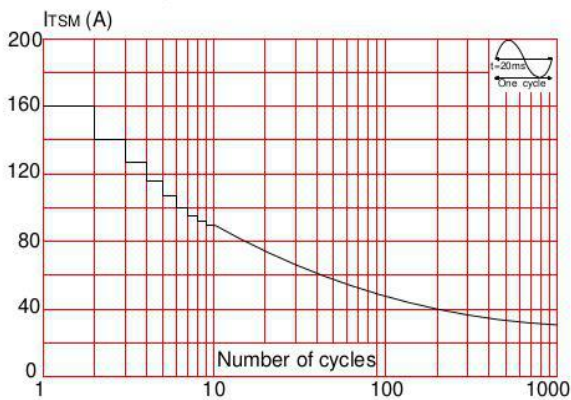
**FIG.1** Maximum power dissipation versus RMS on-state current



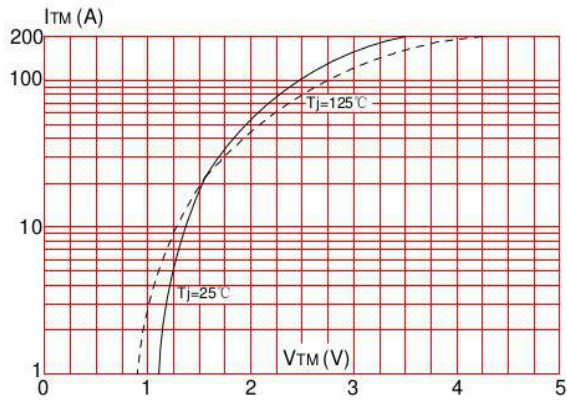
**FIG.2:** RMS on-state current versus case temperature



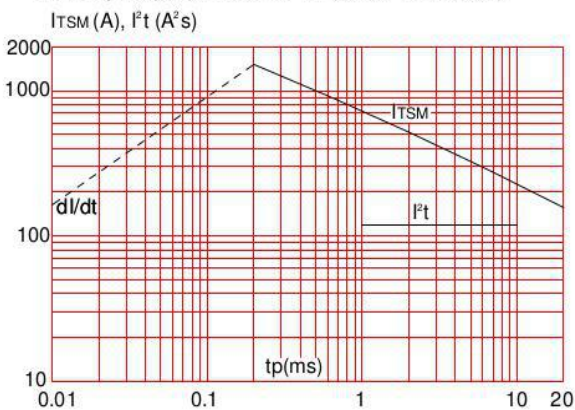
**FIG.3:** Surge peak on-state current versus number of cycles



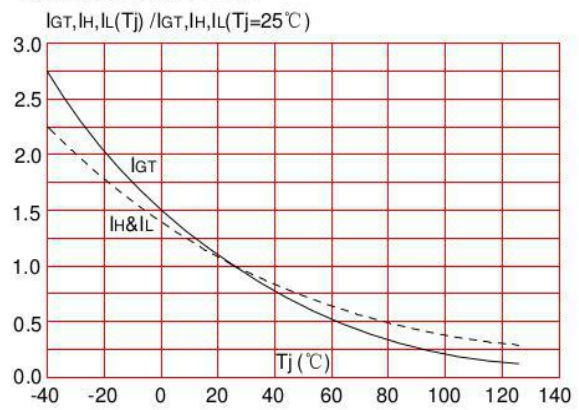
**FIG.4:** On-state characteristics (maximum values)



**FIG.5:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 20\text{ms}$ , and corresponding value of  $I^2t$  ( $di/dt < 50\text{A}/\mu\text{s}$ )



**FIG.6:** Relative variations of gate trigger current, holding current and latching current versus junction temperature







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2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

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